Applicant(s)/Patent Under Application/Control No. Reexamination 09/989,250 VERHAAR ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2818 Chuong A. Luu **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY 438/618 05-1994 Lien et al. US-5,310,700 Α В US-С US-D US-Ε US-US-F US-G US-Н

FOREIGN PATENT DOCUMENTS

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